


<b>Search Notes</b>  	<b>Application/Control No.</b>  10561294	<b>Applicant(s)/Patent Under Reexamination</b>  LEACH ET AL.
	<b>Examiner</b>  PHUTTHIWAT WONGWIAN	<b>Art Unit</b>  4177

SEARCHED			
Class	Subclass	Date	Examiner
60	200.1, 202, 204	5/1/2008	PW

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Primary examiner William Rodriguez for search 60/200.1, 202, 204	4/30/2008	PW
See Plus Search and East History		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner